LXinstruments GmbH Rudolf-Diesel-Str. 36 71154 Nufringen Germany



TECHNICAL PRODUCT INFORMATION

Test & measurement instruments high - quality moderate prices excellent precision

Your contact:

Technical support, services, demo & rental equipment, price information & quotes, consulting:

Tel.: +49(0)7032 / 895 93-3

- Mail: sales@lxinstruments.com
- Web: www.lxinstruments.com
- Shop: www.lxinstruments.com/shop



LCR-8200(A) Series

High Frequency LCR Meter

FEATURES

- Wide Test Frequency : LCR-8200A : DC, 10Hz ~ 50/30/20/10/5 MHz LCR-8200 : DC, 10Hz ~ 30/20/10/5/1 MHz
- 7" LCD color Display
- 0.08% Basic Accuracy
- Displaying Four Measurement Results Simultaneously From 17 Selectable Measurement Parameters Freely
- 15 Steps List Measurement
- Two Curves Sweep Mode
- Equivalent Circuit Model Analysis (LCR-8200A only)
- Internal DC Bias Voltage ±12V
- USB Storage Available
- ALC Function Available
- Standard Interfaces : RS-232C, USB Host/Device, LAN, GPIB and Handler
- Universal Power Input



GW Instek's high-frequency LCR tester ~ LCR-8200 (A), which includes two series, LCR-8200A and LCR-8200, has ten models and the maximum test frequency is up to 50MHz. The entire series adopts 7-inch color display and features a high measurement accuracy (0.08%). The measurement results can be presented numerically or graphically according to the selected measurement mode, allowing users to optimally interpret the characteristics of the DUT. At the same time, a full range of standard interfaces such as USB device / RS-232C / Handler and GPIB allow users to control the instrument by the most familiar interface without worrying about additional hardware investment costs. Furthermore, the series also provides USB storage function when operating in the graphics mode. The measured characteristic curves and values of the DUT are saved for subsequent analysis. The wide variety of features of the LCR-8200 (A) can help users easily respond to the test requirements of passive components in R&D, engineering, and production.

Under the numerical measurement mode, it is divided into MEAS measurement and LIST measurement. Under the MEAS measurement mode, users can select up to 4 (at least 1) desired measurement items from the 17 measurement parameters. Each selected measurement item can be set to compare (PASS/FAIL judgement) or to the BIN function to conduct judgement and sorting, so that users can easily learn the results of the measurement by color and sound. Under the LIST mode, users is allowed to set 15 test points and each test point can set parameters independently, including frequency/voltage/bias, and it even can set independent comparison function and numerical display mode (value, difference value, difference percentage). On top of that, under the LIST mode, the automatic trigger mode is also provided. After each LIST measurement is completed, the instrument will be in the mechanism of standby trigger. Users only need to place the next DUT, and the LIST test can be automatically performed that saves time of repeatedly pressing the trigger button.

Under the graphical measurement mode, the SWEEP measurement provides the ability to sweep two parameters simultaneously (TRACE A / TRACE B). The relative parameters of the sweep, including the sweep source (frequency, voltage, current or bias voltage), horizontal / vertical axis scale (LINEAR / LOG), speed...etc., even adding a bias, can be set and tested according to the actual needs of users. Besides, the LCR-8200A series provides 7 different equivalent circuit models which allows user analysis by 3-components or 4-components combination to characterize the operational characteristics of the circuit. After the sweep is completed, the scale can be automatically adjusted according to the selected TRACE, so that the whole observation is clearer and easier to read. Other than that, the sweep traphics (bmp) and values (csv) can be saved to the flash drive for subsequent analysis and applications.

Whether it is for measurement data collection during the test process or the collocation for the system integration, the LCR-8200 (A) series offers the most comprehensive communications interfaces, including USB device, RS-232C, LAN for PC connection and even GPIB, which are all standard communications interfaces. Users can choose according to the habits of use and the convenience of the system architecture without any additional cost. In addition, the LCR-8200 (A) series also provides a Handler interface for system integration of PLCs or sorters.



PANEL INTRODUCTION

A. THE PRESENTATION OF FLEXIBLE MEASUREMENT COMBINATIONS



LCR-8200(A) Series allows users to select and arrange measurement parameters. Users can select at least one parameter to maximum four parameters from the 17 measurement parameters according to the measurement requirements and the presentation order can also be arranged in a desired manner. The set parameters can be stored in internal/external memory groups for subsequent recalls.

LIST MEASUREMENT



The 15-point LIST measurement mode provides measurement values at a specific frequency or voltage of the DUT, and each set point can set independent comparison and judgement. When the trigger mode is set to "AUTO", the display "WAIT ON" will appear on the measurement screen and LCR-8200(A) Series will detect the contact status of the fixture. When the DUT is connected, the test will start automatically.

Ls = 26.013 kH Q 2.91 Rs 56.080 MΩ R 30.952 MΩ

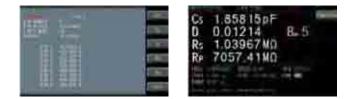
Each selected test parameter can independently set judgement and comparison such as value, difference value or difference percentage. Additionally, the display method can also be based on value, difference value or difference percentage to self-define the presentation of test results, and the observation is more in line with the actual needs. In addition to using the warning sound, all the parameters set for comparison judgment will be displayed in different colors. "Red" means that the limit value is exceeded, and "Green" means that it is within the limit value, so that the judgment can be conducted smoothly under noisy environment.

D. TWO-CURVE SWEEP



Up to 2 characteristic parameters of the DUT can be swept at the same time. Sweep type (frequency/Vac/Iac), axis form (LOG/LINEAR), sweep speed, even adding bias (internal), etc can be set according to the actual demands. After the sweep is completed, automatic adjustment can be used to obtain the best observation display. The movable cursor can be used to obtain the measurement result of the specific position. Swept displays and point values can be saved to the flash drive via the USB host on the panel for subsequent analysis.

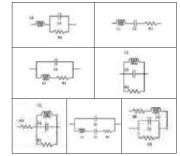
E. BIN FUNCTION



BIN settings for one specific parameter of the selected measurement parameters provide up to 9 BIN positions. Set the judgment basis for individual classifications according to the desired BIN methods (EQUAL/SEQUENTIAL/TOLERANCE/RANDOM) and limit value mode (VALUE/delta/delta%). The result of this sorting can be obtained through the Handler interface. If directly connected to an external device such as a sorter, an immediate sorting can be performed.

F. EQUIVALENT CIRCUIT MODEL ANALYSIS





This function, which adopts the algorithm based on resonance theory, consists of 7 different equivalent circuit models. The 3-components analysis model is composed of 4 types, A, B, C and D, whereas the 4-components analysis model covers 3 types, E, F and G. By selecting suitable equivalent circuit model, the instrument will automatically calculate approximate value of each component parameter after measurement, and generate simulated curve (TRACE A/B SIMULATION) to compare with the measured curve (TRACE A/B).

Also, it's available to choose equivalent circuit model followed by directly input value of each component parameter to generate a simulated curve (TRACE A/B SIMULATION) to further compare with the measured curve (TRACE A/B). The parameters of both resonance frequency (SRF) and quality factor (Qm) can be displayed simultaneously.

B. INDEPENDENT SETTING JUDGMENT

SPECIFICATION	IS			1		
	LCR-8250A	LCR-8230A	LCR-8220A	LCR-8210A	LCR-8205A	-
	-	LCR-8230	LCR-8220	LCR-8210	LCR-8205	LCR-8201
TEST FREQUENCY	1	I	1	1	1	1
	DC, 10Hz~50MHz;	DC, 10Hz~30MHz;	DC, 10Hz~20MHz;	DC, 10Hz~10MHz;	DC, 10Hz~5MHz;	DC, 10Hz~1MHz;
	6 Digits, ±0.0007%	6 Digits, ±0.0007%	6 Digits, ±0.0007%	6 Digits, ±0.0007%	6 Digits, ±0.0007%	6 Digits, ±0.0007%
OUTPUT IMPEDANCE	1					
	25Ω / 100Ω SELECTA	BLE				
BASIC ACCURACY	±0.08%					
TEST SPEED	±0.08%					
TEST SPEED	MAX: 2 5ms(>10kHz)	, FAST: 50ms(>20Hz), M	EDIUM: 100ms, SLOW: 3	300ms, SLOW2: 600ms		
TEST SIGNAL LEVEL		,	,			
AC Voltage	10mV ~ 2Vrms (FREQ.	≦1MHz), 10mV ~ 1Vrm	ns (FREQ. > 1MHz or FR	EQ. ≤ 1 MHz and RO=25	iΩ)	
AC Current	100 μ A ~ 20mArms (RO=100 Ω), 200 μ A ~ 40mArms (RO=25 Ω)					
DCR Voltage	1Vdc (40mA max.)					
MEASUREMENT PARAME	1					
		eters can be measured ar				
	AC Resistance (Rs / Rp Susceptance (B), DC R	o), Quality Factor (Q), Dis	ssipation Factor (D), Adn	nittance (Y), Conductanc	e (G), Reactance (X), Ph	ase Angle (θ d / θ r),
		esistance (Ruc)				
LIST MEASUREMENT Listed Steps	15					
Listed Parameters	Freq/Vac/lac/DC Bias/Comp/BIN					
Trigger	AUTO, REPEAT, SINGLE					
SWEEP MEASUREMENT	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,					
Swept Graphical	Two of measurement	parameters				
Swept Parameters	Freq/Vac/Iac/BIAS V, H					
EQUIVALENT CIRCUIT M	ODEL ANALYSIS ("A" seri	es only)				
	7 different equivalent	circuit models, 3-compoi	nents, 4 types, 4-compor	ients, 3 types		
OTHER FUNCTIONS						
Auto Level Control (ALC)	Standard					
DC Bias	0~±12V					
Handler	PASS, FAIL and OK, N	G or BIN 1-9				
OTHER FEATURES						
Correction	Open/Short/HF Load	/Load				
V/I Monitor	Vac, Iac, Vdc, Idc					
Comparator	Value, Δ , Δ %					
Buzzer Average	OFF, Pass, Fail 1 to 64					
DISPLAY	11001					
	7" LCD color display (8	300 x 480)				
INTERFACE	1	/				
	USB/GPIB/LAN/RS-23	2/Handler/USB Host/TF	IGGER Input			
POWER SOURCE	1					
		Hz; Consumption: 65VA (max.)			
DIMENSIONS & WEIGHT						
Difference between "A" series and		5 (D) mm; Approx. 3.3kg		Specifications	subject to change without r	notice. LCR-8000ACD
				Specifications	subject to change without i	Iotice. ECK-8000ACD
ORDERING INFORM				er Cord x 1, Test Fixture LCI	R-06B x 1, Safety Sheet x 1	
	50MHz High Frequency I	CR Meter	TION		,	
				l & Radial Lead Compone	ents LCR-15A Test F	ixture for SMD/Chip
-7 -	20MHz High Frequency I 10MHz High Frequency I	CR Meter	(up to 50MHz)		comp	onents (up to 50MHz)
,	5MHz High Frequency L		-06B Test Lead with Kelvi		GTL-234 RS-232	
	30MHz High Frequency I	CD Mater	-07 Test Lead with Alliga	1 (// /	GTL-248 GPIB	
				s) for SMD/Chip Compon	ents GTL-246 USB C	apie
LCR-8230 DC, 10Hz~						
LCR-8230 DC, 10Hz~ LCR-8220 DC, 10Hz~	20MHz High Frequency I	CR Meter LCR	-10A Test Fixture for Botto			al DC Bias Voltage Box
LCR-8230 DC, 10Hz~ LCR-8220 DC, 10Hz~ LCR-8210 DC, 10Hz~		CR Meter LCR CR Meter CR Meter LCR		m Electrode Components n clip (4 wire type)		



GOOD WILL INSTRUMENT CO., LTD. No.7-1, Jhongsing Road, Tucheng Dist., New Taipei City 236, Taiwan T +886-2-2268-0389 F +886-2-2268-0639 E-mail: marketing@goodwill.com.tw



